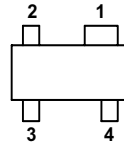


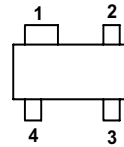
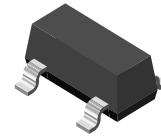
## N-Channel Dual Gate MOS-Fieldeffect Tetrode, Depletion Mode

### Features

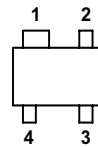
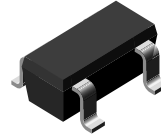
- Integrated gate protection diodes
- Low noise figure
- Low feedback capacitance
- High cross modulation performance
- Low input capacitance
- High AGC-range
- High gain
- Lead (Pb)-free component
- Component in accordance to RoHS 2002/95/EC and WEEE 2002/96/EC



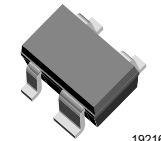
SOT-143



SOT-143R



SOT-343R



19216



Electrostatic sensitive device.  
Observe precautions for handling.

### Applications

Input and mixer stages in UHF tuners.

### Mechanical Data

**Typ:** BF998

**Case:** SOT-143 Plastic case

**Weight:** approx. 8.0 mg

**Marking:** MO

**Pinning:**

1 = Source, 2 = Drain,

3 = Gate 2, 4 = Gate 1

**Typ:** BF998R

**Case:** SOT-143R Plastic case

**Weight:** approx. 8.0 mg

**Marking:** MOR

### Pinning:

1 = Source, 2 = Drain,

3 = Gate 2, 4 = Gate 1

**Typ:** BF998RW

**Case:** SOT-343R Plastic case

**Weight:** approx. 6.0 mg

**Marking:** WMO

**Pinning:**

1 = Source, 2 = Drain,

3 = Gate 2, 4 = Gate 1

### Parts Table

Part	Ordering Code	Marking	Package
BF998	BF998A-GS08 or BF998B-GS08	MO	SOT143
BF998A	BF998A-GS08	MO	SOT143
BF998B	BF998B-GS08	MO	SOT143
BF998R	BF998RA-GS08 or BF998RB-GS08	MOR	SOT143R
BF998RA	BF998RA-GS08	MOR	SOT143R
BF998RB	BF998RB-GS08	MOR	SOT143R
BF998RW	BF998RAW-GS08 or BF998RBW-GS08	WMO	SOT343R
BF998RAW	BF998RAW-GS08	WMO	SOT343R
BF998RBW	BF998RBW-GS08	WMO	SOT343R

### Absolute Maximum Ratings

T<sub>amb</sub> = 25 °C, unless otherwise specified

Parameter	Test condition	Symbol	Value	Unit
Drain - source voltage		V <sub>DS</sub>	12	V
Drain current		I <sub>D</sub>	30	mA
Gate 1/Gate 2 - source peak current		± I <sub>G1/G2SM</sub>	10	mA
Gate 1/Gate 2 - source voltage		± V <sub>G1S/G2S</sub>	7	V
Total power dissipation	T <sub>amb</sub> ≤ 60 °C	P <sub>tot</sub>	200	mW
Channel temperature		T <sub>Ch</sub>	150	°C
Storage temperature range		T <sub>stg</sub>	- 65 to + 150	°C

### Maximum Thermal Resistance

Parameter	Test condition	Symbol	Value	Unit
Channel ambient	1)	R <sub>thChA</sub>	450	K/W

1) on glass fibre printed board (25 x 20 x 1.5) mm<sup>3</sup> plated with 35 µm Cu

### Electrical DC Characteristics

T<sub>amb</sub> = 25 °C, unless otherwise specified

Parameter	Test condition	Part	Symbol	Min	Typ.	Max	Unit
Drain - source breakdown voltage	I <sub>D</sub> = 10 µA, - V <sub>G1S</sub> = - V <sub>G2S</sub> = 4 V		V <sub>(BR)DS</sub>	12			V
Gate 1 - source breakdown voltage	± I <sub>G1S</sub> = 10 mA, V <sub>G2S</sub> = V <sub>DS</sub> = 0		± V <sub>(BR)G1SS</sub>	7		14	V
Gate 2 - source breakdown voltage	± I <sub>G2S</sub> = 10 mA, V <sub>G1S</sub> = V <sub>DS</sub> = 0		± V <sub>(BR)G2SS</sub>	7		14	V
Gate 1 - source leakage current	± V <sub>G1S</sub> = 5 V, V <sub>G2S</sub> = V <sub>DS</sub> = 0		± I <sub>G1SS</sub>			50	nA
Gate 2 - source leakage current	± V <sub>G2S</sub> = 5 V, V <sub>G1S</sub> = V <sub>DS</sub> = 0		± I <sub>G2SS</sub>			50	nA
Drain current	V <sub>DS</sub> = 8 V, V <sub>G1S</sub> = 0, V <sub>G2S</sub> = 4 V	BF998/ BF998R/ BF998RW	I <sub>DSS</sub>	4		18	mA
		BF998A/ BF998RA/ BF998RAW	I <sub>DSS</sub>	4		10.5	mA
		BF998B/ BF998RB/ BF998RBW	I <sub>DSS</sub>	9.5		18	mA
Gate 1 - source cut-off voltage	V <sub>DS</sub> = 8 V, V <sub>G2S</sub> = 4 V, I <sub>D</sub> = 20 µA		- V <sub>G1S(OFF)</sub>		1.0	2.0	V
Gate 2 - source cut-off voltage	V <sub>DS</sub> = 8 V, V <sub>G1S</sub> = 0, I <sub>D</sub> = 20 µA		- V <sub>G2S(OFF)</sub>		0.6	1.0	V

### Electrical AC Characteristics

T<sub>amb</sub> = 25 °C, unless otherwise specified

V<sub>DS</sub> = 8 V, I<sub>D</sub> = 10 mA, V<sub>G2S</sub> = 4 V, f = 1 MHz

Parameter	Test condition	Symbol	Min	Typ.	Max	Unit
Forward transadmittance		y <sub>21s</sub>	21	24		mS
Gate 1 input capacitance		C <sub>issg1</sub>		2.1	2.5	pF
Gate 2 input capacitance	V <sub>G1S</sub> = 0, V <sub>G2S</sub> = 4 V	C <sub>issg2</sub>		1.1		pF
Feedback capacitance		C <sub>rss</sub>		25		fF
Output capacitance		C <sub>oss</sub>		1.05		pF



Parameter	Test condition	Symbol	Min	Typ.	Max	Unit
Power gain	$G_S = 2 \text{ mS}, G_L = 0.5 \text{ mS}, f = 200 \text{ MHz}$	$G_{ps}$		28		dB
	$G_S = 3,3 \text{ mS}, G_L = 1 \text{ mS}, f = 800 \text{ MHz}$	$G_{ps}$	16.5	20		dB
AGC range	$V_{G2S} = 4 \text{ to } -2 \text{ V}, f = 800 \text{ MHz}$	$\Delta G_{ps}$	40			dB
Noise figure	$G_S = 2 \text{ mS}, G_L = 0.5 \text{ mS}, f = 200 \text{ MHz}$	F		1.0		dB
	$G_S = 3,3 \text{ mS}, G_L = 1 \text{ mS}, f = 800 \text{ MHz}$	F		1.5		dB

## Common Source S-Parameters

$T_{amb} = 25 \text{ }^\circ\text{C}$ , unless otherwise specified

$V_{DS} = 8 \text{ V}, V_{G2S} = 4 \text{ V}, Z_0 = 50 \text{ } \Omega$

ID/mA	f/MHz	S11		S21		S12		S22	
		LOG MAG	ANG	LOG MAG	ANG	LOG MAG	ANG	LOG MAG	ANG
			deg		deg		deg		deg
5	100	-0.03	-7.2	5.71	168.8	-55.94	83.6	-0.08	-3.6
	200	-0.15	-14.1	5.51	157.3	-50.26	76.8	-0.13	-7.0
	300	-0.34	-20.9	5.20	134.7	-48.51	67.7	-0.29	-9.7
	400	-0.70	-32.1	2.01	121.3	-46.98	62.8	-0.44	-12.3
	500	-1.03	-39.2	1.45	108.4	-46.40	57.8	-0.59	-15.1
	600	-1.33	-45.8	0.94	96.5	-46.40	57.3	-0.76	-17.4
	700	-1.62	-52.3	0.43	85.0	-47.02	58.9	-0.91	-19.7
	800	-1.92	-58.7	-0.10	74.1	-47.53	63.3	-1.08	-22.0
	900	-2.21	-64.7	-0.59	63.6	-47.81	73.1	-1.26	-24.3
	1000	-2.49	-70.7	-1.12	53.1	-48.52	83.5	-1.45	-26.2
	1100	-2.80	-76.6	-1.52	43.7	-48.53	102.1	-1.57	-28.4
	1200	-3.07	-82.5	-1.93	33.6	-46.95	120.4	-1.75	-30.5
1300	-3.31	-88.6	-2.35	24.1	-44.44	131.7	-1.92	-32.7	
10	100	-0.05	-9.0	5.19	165.3	-56.24	81.9	-0.11	-3.5
	200	-0.16	-18.7	5.58	151.8	-49.97	75.0	-0.21	-7.2
	300	-0.48	-26.0	4.45	136.3	-47.91	67.2	-0.33	-9.8
	400	-0.76	-33.7	3.95	123.3	-46.48	61.8	-0.47	-12.6
	500	-1.11	-41.2	3.40	110.9	-45.91	56.3	-0.65	-15.3
	600	-1.43	-48.3	2.88	99.5	-45.91	55.8	-0.81	-17.8
	700	-1.75	-55.1	2.39	88.7	-46.53	56.7	-0.96	-20.0
	800	-2.07	-61.6	1.88	78.1	-47.13	60.7	-1.12	-22.4
	900	-2.40	-67.9	1.39	67.9	-47.41	69.9	-1.32	-24.6
	1000	-2.70	-74.2	0.90	57.9	-48.21	80.0	-1.49	-26.6
	1100	-3.03	-80.2	0.50	48.7	-48.43	98.9	-1.61	-28.8
	1200	-3.32	-86.4	0.13	38.9	-47.04	118.2	-1.79	-31.0
1300	-3.59	-92.3	-0.28	29.6	-44.54	130.5	-1.96	-33.3	
15	100	-0.05	-9.4	6.07	165.4	-55.74	81.4	-0.15	-3.6
	200	-0.17	-19.4	6.44	152.0	-49.47	74.6	-0.24	-7.3
	300	-0.50	-27.1	5.31	136.7	-47.41	66.4	-0.36	-10.0
	400	-0.81	-35.0	4.80	123.8	-45.98	60.8	-0.52	-12.9
	500	-1.18	-42.9	4.23	111.5	-45.41	55.1	-0.68	-15.7
	600	-1.52	-50.3	3.72	100.3	-45.41	54.4	-0.84	-18.0
	700	-1.86	-57.2	3.22	89.6	-46.13	54.9	-1.02	-20.4
	800	-2.20	-63.9	2.72	79.4	-46.63	58.5	-1.16	-22.7
	900	-2.53	-70.4	2.24	69.2	-47.00	67.3	-1.35	-25.0
	1000	-2.86	-76.8	1.74	59.4	-47.91	76.7	-1.53	-27.1
	1100	-3.21	-82.9	1.34	50.2	-48.33	95.2	-1.66	-29.4
	1200	-3.50	-89.0	0.95	40.8	-47.04	115.3	-1.84	-31.6
1300	-3.80	-95.1	0.56	31.5	-44.53	128.7	-2.00	-33.9	

## Typical Characteristics ( $T_{amb} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified)

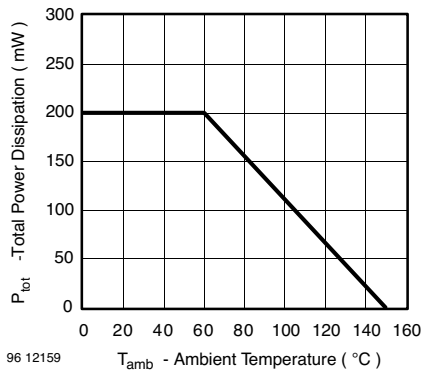


Figure 1. Total Power Dissipation vs. Ambient Temperature

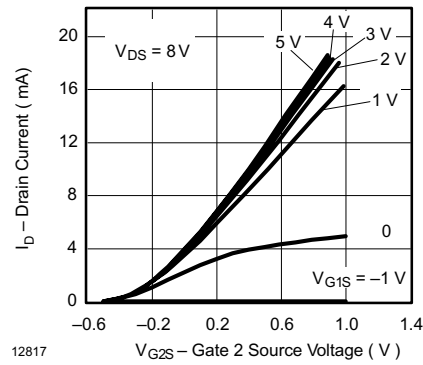


Figure 4. Drain Current vs. Gate 2 Source Voltage

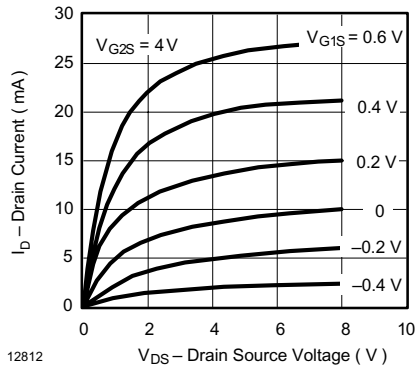


Figure 2. Drain Current vs. Drain Source Voltage

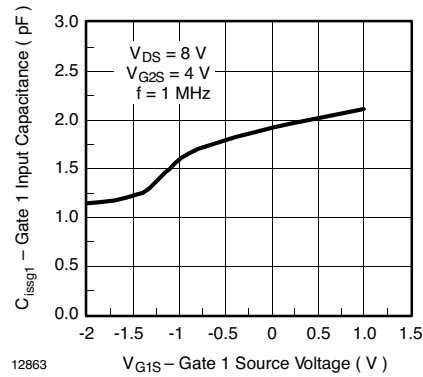


Figure 5. Gate 1 Input Capacitance vs. Gate 1 Source Voltage

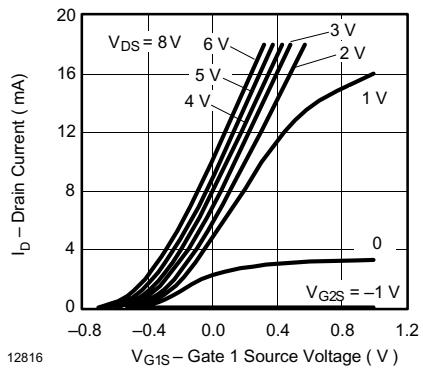


Figure 3. Drain Current vs. Gate 1 Source Voltage

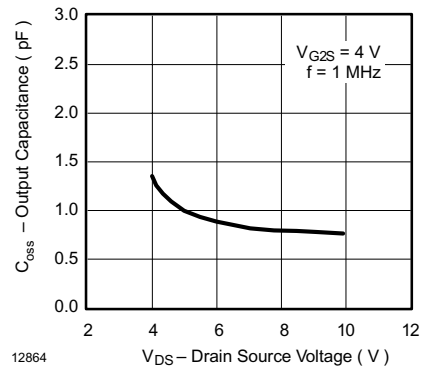


Figure 6. Output Capacitance vs. Drain Source Voltage

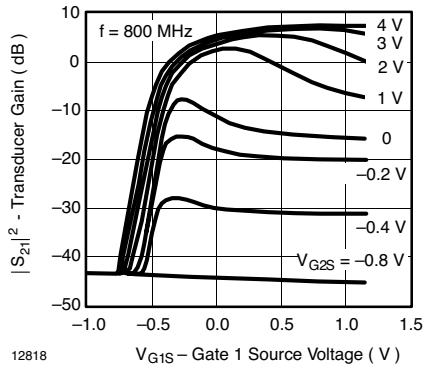


Figure 7. Transducer Gain vs. Gate 1 Source Voltage

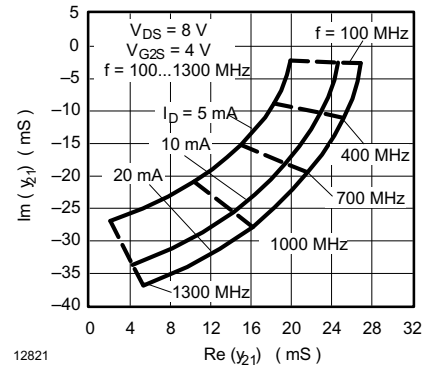


Figure 10. Short Circuit Forward Transfer Admittance

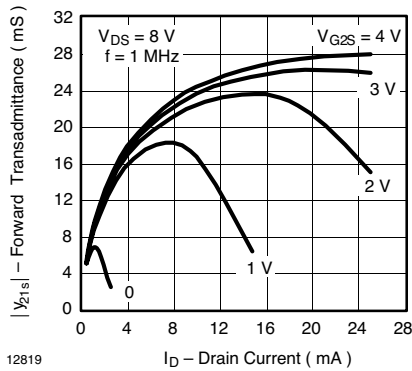


Figure 8. Forward Transadmittance vs. Drain Current

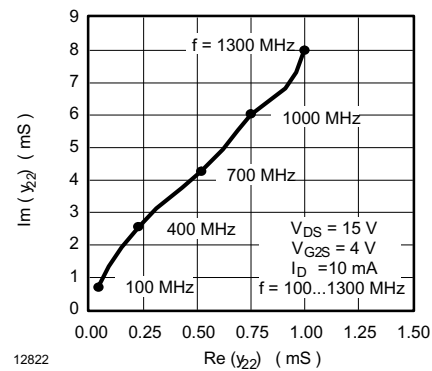


Figure 11. Short Circuit Output Admittance

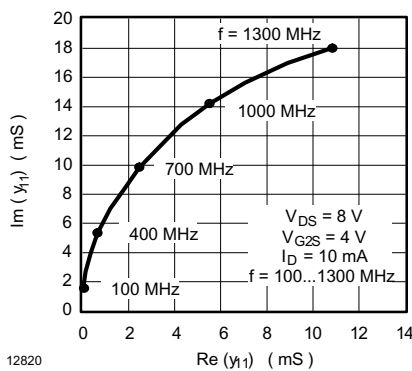
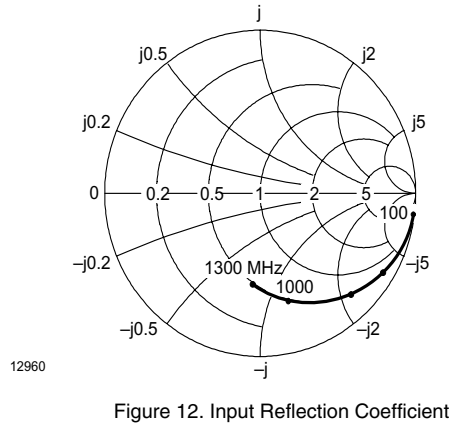
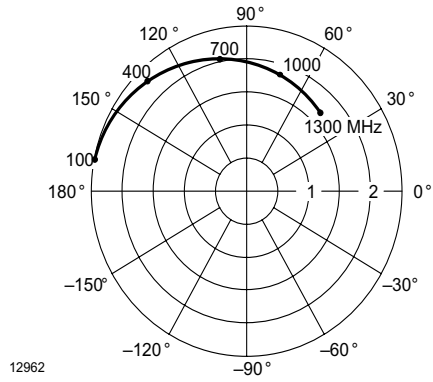


Figure 9. Short Circuit Input Admittance

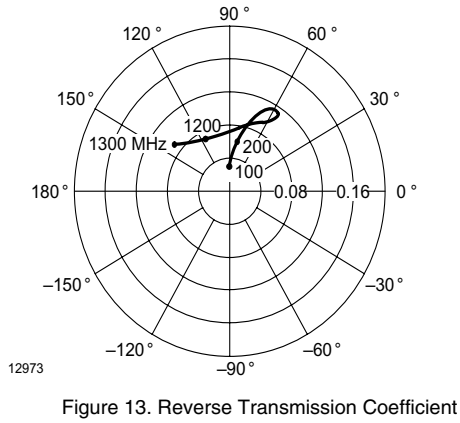
$V_{DS} = 8 \text{ V}$ ,  $I_D = 10 \text{ mA}$ ,  $V_{GS} = 4 \text{ V}$ ,  $Z_0 = 50 \Omega$   
 $S_{11}$



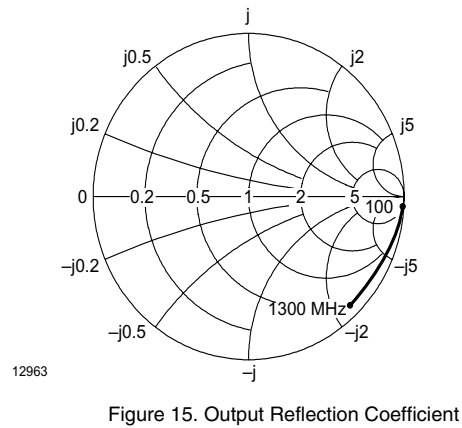
$S_{21}$



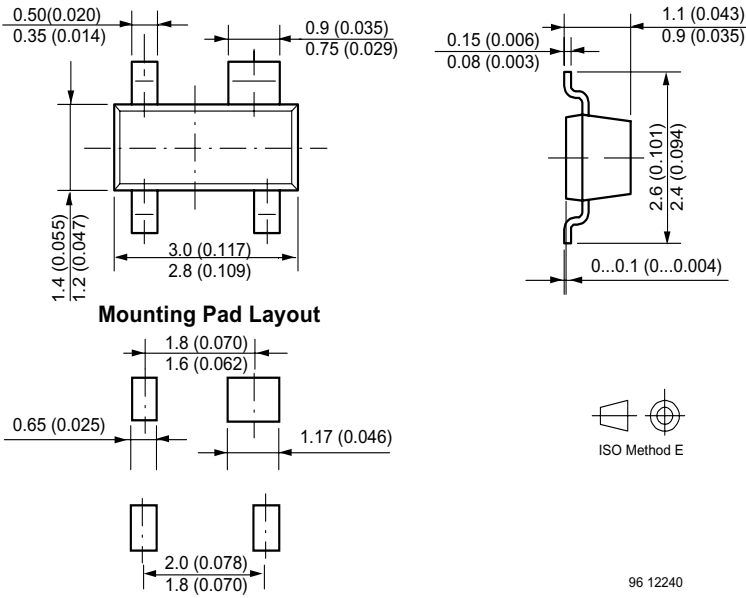
$S_{12}$



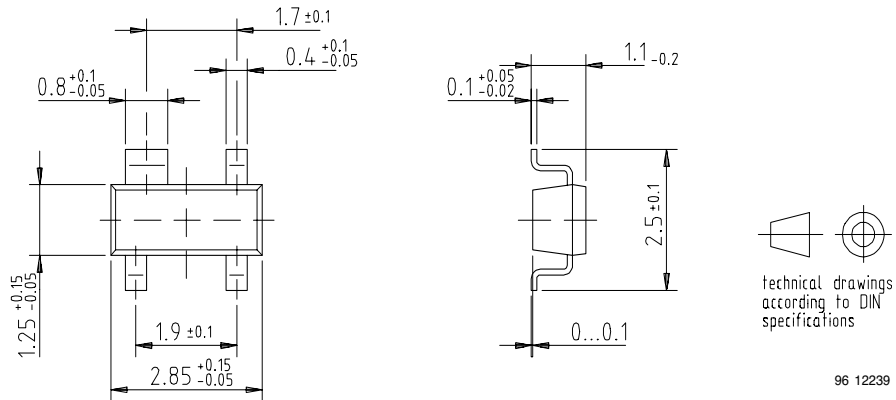
$S_{22}$



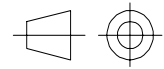
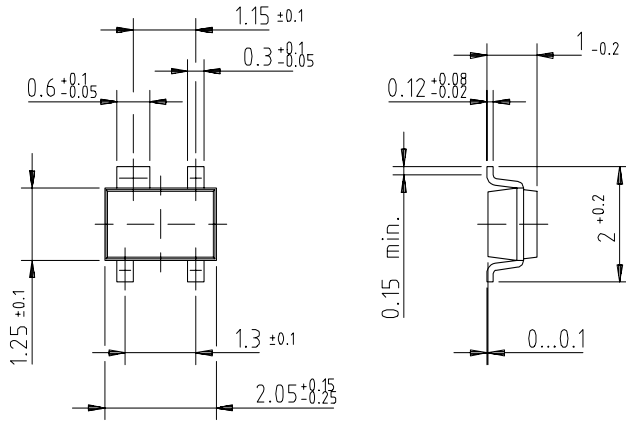
## Package Dimensions of SOT143 in mm



## Package Dimensions of SOT143R in mm



## Package Dimensions of SOT343R in mm



technical drawings  
according to DIN  
specifications

96 12238



**Ozone Depleting Substances Policy Statement**

It is the policy of Vishay Semiconductor GmbH to

1. Meet all present and future national and international statutory requirements.
2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

Vishay Semiconductor GmbH has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

Vishay Semiconductor GmbH can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

We reserve the right to make changes to improve technical design  
and may do so without further notice.

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Vishay Semiconductor GmbH, P.O.B. 3535, D-74025 Heilbronn, Germany



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